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A Refinement of the Parameters of α Manganese

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The atomic parameters of α manganese, first determined by Bradley & Thewlis (1927), have been refined from an *R* index of 0.093 to a final *R* of 0.029 for fifty reflections. This refinement was based on an analysis of the integrated intensities of X-ray diffracted powder peaks measured independently at two laboratories. The lattice constant of α manganese was determined from liquid helium temperature up to room temperature and a change in the thermal expansion coefficient was found in the vicinity of the Néel temperature (95°K) although no structural change was observed in this region.

The structure of α manganese as determined by Bradley & Thewlis (1927) is as follows:

Space group $I\bar{4}3m$ no. 217 in International Tables for X-ray Crystallography (1952).

2 Mn(1) in 2(a) 000, etc. 8 Mn(2) in 8(c) xxx, etc. x(2)=0.31724 Mn(3) in 24(g) xxz, etc. x(3)=0.356, z(3)=0.04224 Mn(4) in 24(g) xxz, etc. x(4)=0.089, z(4)=0.278

This result is based on X-ray intensities read from Phragmén-camera photographs taken by Westgren & Phragmén (1925). Kasper & Roberts (1956) checked Bradley & Thewlis's parameters with neutron diffraction data and found them to be accurate enough (± 0.003) to establish the magnetic structure at 4.2, 77, and 298 °K.

In an attempt by Gazzara, Middleton & Weiss to determine the characteristic temperature Θ of α -Mn it was found desirable to refine the structural parameters by applying modern experimental X-ray diffraction techniques. A refinement was performed on twenty-one Cr $K\alpha$ diffraction peaks from powder specimens. During this same time, a similar refinement was performed by E.O. Hall on α -Mn powders using Cu $K\alpha$ radiation. This report presents the best values of the structural parameters obtained from the two investigations.

Although many powder samples were examined in this X-ray diffraction analysis, the data from only four sources were eventually used:

(1) A pure, carbon-free, electrolytic -400 mesh powder. This showed some diffraction peak broadening and gave intensities identical with those of sample (2).

(2) Electrolytic plate, ground mortar and pestle and sifted to -400 mesh particle size. Although the cold working increased the diffraction peak widths, it reduced extinction effects. The integrated intensity of the Cr K α diffraction peak $\Sigma h^2 = 18$, for example, was increased 4% through cold working. All calculations involving Cr K α radiation are based on measurements performed on this material.

(3) A portion of powder sample (2) annealed at 440 °C for 90 hours in vacuum. All of the diffraction peaks obtainable with Cr $K\alpha$ radiation from this sample could be resolved and accurately measured with Mo $K\alpha$ radiation; many of the high-angle Mo $K\alpha$ diffraction peaks were resolved sufficiently well to be integrated. All results obtained with Mo $K\alpha$ radiation were taken

from sample (3) and extinction effects were assumed to be negligible.

(4) A Johnson-Matthey H.S. manganese flake. This was lightly pickled in hydrochloric acid to remove surface oxide, washed, dried and finally crushed in a mortar. This material was used in the investigation by E.O. Hall.

All samples of Mn were contaminated to some degree with MnO. The MnO peaks frequently occurred at the same angles as the Mn peaks and a correction for their contribution was made. Vacuum fusion analyses of samples (1) to (3) indicated 0.40 wt.% oxygen, whereas neutron activation measurements indicated more than 0.60 wt.% oxygen. The integrated intensity of the resolved MnO 211 peak indicated approximately 0.60wt.% oxygen or more.

Preferred orientation in the powder samples was examined using a pole figure sample holder. No significant variation in the integrated intensity of diffraction peak $\Sigma h^2 = 18$ was observed with rotation of the specimen.

The effect of porosity on the integrated intensities was determined from the ratio of the fluorescent intensities of the powder specimens to those from polished electrolytic plates (Cooper, 1962). The ratios were found to be 0.95 ± 0.01 at $(\sin \theta/\lambda)^2 = 0.057$ and $0.98 \pm$ 0.01 at $(\sin \theta/\lambda)^2 = 0.984$ with Cr K α radiation. In the refinement calculations the effect of porosity on the values of the atomic parameters was found to be negligible.

A correction for porosity was made by normalizing the intensity of the Cr $K\alpha \Sigma h^2 = 50$ peak against the reflection $\Sigma h^2 = 19$ from a standard silicon powder specimen. An interesting observation for this α -Mn study is that the refined parameter values were found to be independent of the normalization factor, used to obtain the absolute values of the intensities.

The intensity data were obtained in four different ways:

(i) Twenty-one of the major diffraction peaks $\Sigma h^2 = 6$ through 58 from samples (1) and (2) were investigated at 310 and 100°K, using a General Electric XRD-5 Diffractometer, vanadium filtered Cr $K\alpha$ radiation, (40 kV, 35 mA) and a scintillation counter. The integrated intensities were measured using a technique reported by Gazzara (1960).

(ii) Using the apparatus in (1) with a Mo-target tube (40 kV, 35 mA) and Zr filter. This provided the most reliable intensity data. Several samples were investigated using both a counting technique, and automatic ratemeter chart recordings of 2θ scans. Of the high angle diffraction peaks $\Sigma h^2 > 58$, twenty-nine were resolved and integrated graphically.

(iii) Using a Phillips X-ray generator with a Motarget tube and a LiF monochromator. This system was not sufficient to resolve diffraction peaks $\Sigma h^2 = 54$, 56, 58.

(iv) Using a Phillips PW 1010 X-ray set with a Cutarget tube for step-scanning diffraction peaks $\Sigma h^2 = 6$ through 58. This apparatus was used by E.O. Hall on sample (4).

The lattice constant measurements from 5 to 298 °K were made on sample (3) using a cryostat manufactured by Materials Research Corporation, Orangeburg, New York. The lattice constants were refined by Cohen's (1955) least-squares method; the weighted r.m.s. deviations are indicated in Fig. 1 with vertical bars. The assumed wave lengths were $2 \cdot 28962$ Å (Cr $K\alpha_1$), $2 \cdot 29351$ Å (Cr $K\alpha_2$), $0 \cdot 70926$ Å (Mo $K\alpha_1$) and $0 \cdot 713543$ Å (Mo $K\alpha_2$).

The dispersion corrections used were $\Delta f' = 1.8$ and $\Delta f'' = 0.8$ for Cr K α radiation; $\Delta f' = 0.4$ and $\Delta f'' = 0.8$ for Mo K α radiation; and $\Delta f' = -0.5$ and $\Delta f'' = 3.0$ for Cu K α (Dauben & Templeton, 1955). The scattering factors were taken from Freeman & Watson (1961). All measured intensities were converted to the Mo K α scale and corrected for thermal diffuse scattering (Chipman & Paskin, 1958).

The function Y_i is defined by:

$$Y_j = \frac{I_j}{(\mathrm{LP})G_j^2 e^{-2M}}$$

where

 $I_j =$ normalized integrated intensity of peak j

LP = Lorentz Polarization factor

 $e^{-2M} = \exp\{-2B(\sin \theta/\lambda)^2\} = \text{Debye-Waller factor}$

 G_j = square root of the structure factor term for powder peak j or $G_j = (\Sigma m_i F_i F_i^*)^{\frac{1}{2}}$

 $m_i =$ multiplicity

 $F_i F_i^*$ = the structure factor times its complex conjugate for $(hkl)_i$.

In the refinement of the atomic parameters, the condition was imposed that the slope of $\ln Y_j vs$. $(\sin \theta/\lambda)^2$ be the same for both sets of intensity data taken at 100 and 310°K for one computed value of *B*. This resulted in a value of $B=0.47\pm0.05$ Å² with a characteristic temperature $\Theta = 380\pm20$ °K.

The value of B and the characteristic temperature Θ were more accurately determined from measurements of the ratio of the integrated intensities at 100 to 310°K



Fig. 1. Lattice parameter, a, versus temperature for α manganese. The a values were obtained from Cohen least-squares calculations.

		Gj				Gj				Gj	
		Bradley				Bradley				Bradley	
$\Sigma_{h_1}^{2}$	Observed	and Thewlis	Present Work	Σh_1^2	Observed	and Thewlis	Present Work	Σh_1^2	Observed	and Thewlis	Present Work
2		18	22	108			58 2	218			1106
4		40	15	1 110	1053	1253	1027	222			775
6	125	123	123	114	1395	1245	1377	224			323
8	165	168	164	116			440	226			638
10		78	89	118	1556	1518	1548	228			757
12	206	209	207	120			1214	230	1425	1508	1391
14	231	210	236	122	1272	1386	1359	232			328
16	552	590	546	126	1535	1360	1482	234			965
18	2870	2868	2897	128	1		375	236]		642
20		204	109	130			485	238			285
22	1584	1633	1570	132			263	242	1472	1460	1489
24	1032	1033	1022	134			1408	244			559
26	1328	1273	1329	136	1		807	246			1019
30	355	389	382	138			706	248			906
32	257	164	255	140			319	250			1103
34	317	381	321	142	1		486	254			762
36	418	463	446	144			421	256			454
38	466	567	467	146			944	258			834
40		226	231	148	1		201	260			689
42		248	149	150	1447	1210	1435	262			297
44	648	687	679	152			290	264			839
46	414	342	391	154	1242	1454	1318	266			843
48	1163	1093	1172	158			603	268			208
50	1385	1330	1392	160			509	270			556
52		38	41	162			313	272			612
54	2647	2615	2625	164		[[892	274	1274	1214	1245
56	1096	1104	1083	166	1		760	276			555
58	830	897	794	168			583	278	1254	1487	1311
100	10/7			170			651	280			534
62	1067	1101	1116	1/2		1 1	308	282			820
64	1		55	174	1		495	286			736
00			004	170			481	288			79
70		1	709	1/8	1122	987	1136	290			879
70	1700	1712	1770	100	1 500	1 1616	250	292			726
7/	1/35	1/12	702	19/	1075	1313	1603	294			626
74			53/	194	1151	1062	988	296			504
78			651	190	1151	1062	(22	298			225
80			1/6	192			433	300			202
82	1029	000	1014	192			1274	302			551
84	1025	,,,,,	477	196		1	607	304	1505	1221	831
86	1082	972	1042	198	1	1 1	1090	308	560	1231	1442
88		1	790	200	1090	1088	1130	310	1126	033	1157
90	1535	1467	1508	202	1	1000	449	312	569	226	1137
94		1	692	204	1	1	386	314	170/	1750	400
96	1		435	206	904	1134	985	318	10/2	1210	1103
98	1073	912	1038	208	1		188	320	1042	1213	239
100		1	131	210	1	1 1	554	520			200
102		1	606	212	1	1 1	546	1	1		
104		1	627	214	1		720		1		
106			448	216	1		866				

Table 1. Values of G_j , where $G_j = (\Sigma m_i F_i F_i^*)^{\frac{1}{2}}$, corresponding to the observed powder reflections (column 1), calculated with the atomic parameters of Bradley & Thewlis (column 2), and calculated with the atomic parameters reported in the present investigation (column 3)

Table 2. Interatomic distances in α manganese
The lattice parameter a was taken as 8.9125 Å at 298°K.

Atoms*	Interatomic distance, d, using Bradley & Thewlis's parameters (Å)	Interatomic distance, d, using present parameters (Å)	Coordination number
Mn(1)-4Mn(2) 12Mn(4)	2·83 2·72	2·84 ₀ 2·75 ₂	16
$ \begin{array}{c} Mn(2) - 1 Mn(1) \\ 3 + 3 Mn(3) \\ 6 + 3 Mn(4) \end{array} $	2·83 2·50; 2·96 2·70; 2·89	2·84 ₀ 2·56 ₃ ; 2·91 ₁ 2·72 ₀ ; 2·87 ₇	16
$\frac{Mn(3)-1+1Mn(2)}{6Mn(3)}\\1+2+2Mn(4)$	2·50; 2·96 2·67) 2·45; 2·51; 2·67	$2 \cdot 56_3$; $2 \cdot 91_1$ 4-2 \cdot 65_5; 2-2 \cdot 63_7 2 \cdot 35_1; 2 · 51 ₈ ; 2 · 69 ₁	13
Mn(4)-1Mn(1)2+1Mn(2)1+2+2Mn(3)1+2Mn(4)	2·72 2·70; 2·89 2·45; 2·51; 2·67 2·24; 2·38	$\begin{array}{r} 2.75_2 \\ 2.72_0; \ 2.87_7 \\ 2.35_1; \ 2.51_8; \ 2.69_1 \\ 2.24_4; \ 2.43_3 \end{array}$	12

* The number and type (in parentheses) of neighbors are listed.

(Gazzara, Middleton & Weiss, 1964) of diffraction peaks $\Sigma h^2 = 314 - (0,5,17)(1,12,13)(3,4,17)(3,7,16)(5,8,$ $15)(7,11,12)(8,9,13) and <math>\Sigma h^2 = 318 - (1,11,14)(2,5,17) - (7,10,13)$. These have large values of $\sin \theta/\lambda$ and G_j and were well resolved. Furthermore, the effects of anisotropy on the Debye–Waller factor were considered to be negligible since each peak consists of so many different combinations of h, k, and l. The characteristic temperature was found to be $390 \pm 10^{\circ}$ K with a corresponding value of $B = 0.445 \pm 0.022$ Å². This value was subsequently used in the calculations of Y_j .

A least-squares analysis program was written for an IBM 1620 or 7090 computer in which the atomic parameters were systematically varied so as to maximize the correlation coefficient, r (Weatherburn, 1957), which is defined in terms of Y_j and $(\sin \theta/\lambda)^2$, and to minimize the R index:

$$R = \frac{\sum_{j} |G_{j}(\text{observed}) - G_{j}(\text{calculated})|}{\sum_{j} G_{j}(\text{observed})}$$

In the analysis, each peak was given a weight inversely proportional to the probable error of its absolute intensity.

A refinement utilizing an average of the intensities measured according to all four methods described above and one employing those intensities obtained from method (ii) alone resulted in the same atomic parameters: x(2) = 0.316, x(3) = 0.356, z(3) = 0.034, x(4) = 0.089, z(4) = 0.282, space group $I\bar{4}3m$. For the reflections $\Sigma h^2 = 6$ through 58, the atomic parameters of Bradley & Thewlis yielded an R index of 4.9% and an r index of 0.29 compared with an R of 1.4% and an r of 0.76 using the refined parameters. For all fifty reflections listed in Table 1, R is 9.3% with Bradley & Thewlis's parameters and 2.9% with our parameters. No significant change in the atomic parameters was found between 310 and 100°K. Although the plot shown in Fig.1 reveals a marked change in the lattice constant in the vicinity of the Néel temperature, no structural change could be detected on examination of the intensities of the diffraction peaks $\Sigma h^2 = 16,18,26$ above and below the Néel temperature. The lattice constant at 298°K was found to be 8.9125 Å, in agreement with the reported values of a = 8.9139 Å (Carapella & Hultgren, 1942) and a=8.9120 (Carlile, Christian & Hume-Rothery, 1949). The values of G_j calculated both with the atomic parameters of Bradley & Thewlis and with our refined parameters are given in Table 1 together with those values of G_j that correspond to the observed absolute intensities.

The interatomic distances are given in Table 2 for a=8.9125 Å at 298 °K.

A special tribute should be extended to A.J. Bradley and J. Thewlis for the accuracy of their diffraction work and computations without the use of modern diffraction equipment and high speed computers. Indeed, except for the z(3) parameter, there would have been little justification to perform this refinement.

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